

# 1-Mbit (128 K × 8/64 K × 16) nvSRAM with Real Time Clock

#### **Features**

- 1-Mbit nonvolatile static random access memory (nvSRAM)
- □ 25 ns and 45 ns access times
- □ Internally organized as 128 K × 8 (CY14B101KA) or 64 K × 16 (CY14B101MA)
- ☐ Hands off automatic STORE on power-down with only a small capacitor
- STORE to QuantumTrap nonvolatile elements is initiated by software, hardware, or AutoStore on power-down
- □ RECALL to SRAM initiated on power-up or by software
- High reliability
  - □ Infinite Read, Write, and RECALL cycles
  - ☐ 1 million STORE cycles to QuantumTrap
  - □ 20 year data retention
- Real time clock (RTC)
  - □ Full featured real time clock
  - Watchdog timer
  - Clock alarm with programmable interrupts
  - □ Capacitor or battery backup for RTC
  - □ Backup current of 0.35 µA (Typ)

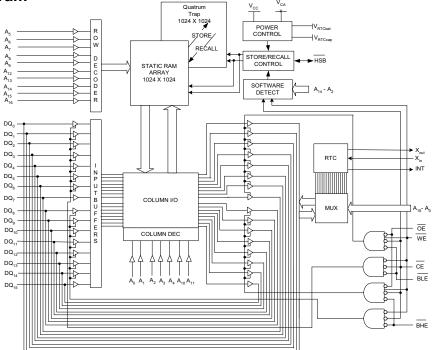
- Industry standard configurations
  - □ Single 3 V +20%, -10% operation
  - □ Industrial temperature
- Packages
  - □ 44-/54-pin thin small outline package (TSOP) Type II
  - □ 48-pin shrink small outline package (SSOP)
- Pb-free and restriction of hazardous substances (RoHS) compliant

#### **Functional Description**

The Cypress CY14B101KA/CY14B101MA combines a 1-Mbit nvSRAM with a full featured real time clock in a monolithic integrated circuit. The embedded nonvolatile elements incorporate QuantumTrap technology producing the world's most reliable nonvolatile memory. The SRAM is read and written an infinite number of times, while independent nonvolatile data resides in the nonvolatile elements.

The real time clock function provides an accurate clock with leap year tracking and a programmable, high accuracy oscillator. The alarm function is programmable for periodic minutes, hours, days, or months alarms. There is also a programmable watchdog timer for process control.

### Logic Block Diagram<sup>[1, 2, 3]</sup>



- 1. Address  $A_0$ – $A_{16}$  for  $\mathbf{x}$  8 configuration and Address  $A_0$ – $A_{15}$  for  $\mathbf{x}$  16 configuration.
- 2. Data  $DQ_0 DQ_7$  for  $\times$  8 configuration and Data  $DQ_0 DQ_{15}$  for  $\times$  16 configuration.
- 3. BHE and BLE are applicable for x 16 configuration only.



#### **Contents**

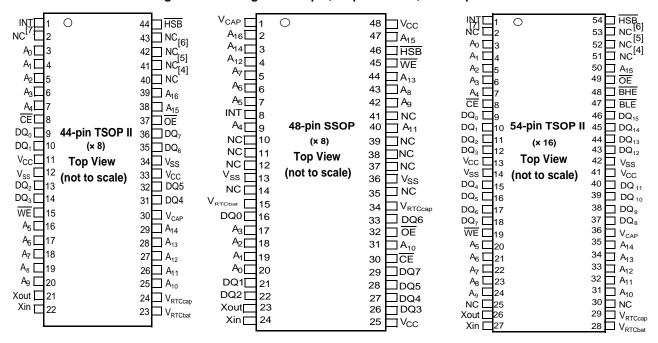
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#### **Pinouts**

Figure 1. Pin Diagram - 44-pin, 54-pin TSOP II, and 48-pin SSOP



- 4. Address expansion for 2-Mbit. NC pin not connected to die.
- 5. Address expansion for 4-Mbit. NC pin not connected to die.
- 6. Address expansion for 8-Mbit. NC pin not connected to die.
- 7. Address expansion for 16-Mbit. NC pin not connected to die.



### **Pin Definitions**

Pin Name	I/O Type	Description
A <sub>0</sub> -A <sub>16</sub>	Input	Address inputs. Used to select one of the 131,072 Bytes of the nvSRAM for × 8 configuration.
A <sub>0</sub> -A <sub>15</sub>	Input	Address inputs. Used to select one of the 65,536 Words of the nvSRAM for x 16 configuration.
DQ <sub>0</sub> -DQ <sub>7</sub>	Input/Output	Bidirectional data I/O Lines for x 8 configuration. Used as input or output lines depending on operation.
DQ <sub>0</sub> -DQ <sub>15</sub>	input/Output	Bidirectional data I/O Lines for × 16 configuration. Used as input or output lines depending on operation.
NC	No connect	No connects. This pin is not connected to the die.
WE	Input	Write Enable input, Active LOW. When the chip is enabled and $\overline{\text{WE}}$ is LOW, data on the I/O pins is written to the specific address location.
CE	Input	Chip Enable input, Active LOW. When LOW, selects the chip. When HIGH, deselects the chip.
ŌĒ	Input	Output Enable, Active LOW. The active LOW OE input enables the data output buffers during read cycles. Deasserting OE HIGH causes the I/O pins to tristate.
BHE	Input	Byte High Enable, Active LOW. Controls DQ <sub>15</sub> -DQ <sub>8</sub> .
BLE	Input	Byte Low Enable, Active LOW. Controls DQ <sub>7</sub> –DQ <sub>0</sub> .
X <sub>out</sub> <sup>[8]</sup>	Output	Crystal connection. Drives crystal on start up.
X <sub>in</sub> [8]	Input	Crystal connection. For 32.768 kHz crystal.
V <sub>RTCcap</sub> <sup>[8]</sup>	Power supply	Capacitor supplied backup RTC supply voltage. Left unconnected if V <sub>RTCbat</sub> is used.
V <sub>RTCbat</sub> <sup>[8]</sup>	Power supply	Battery supplied backup RTC supply voltage. Left unconnected if V <sub>RTCcap</sub> is used.
INT <sup>[8]</sup>	Output	Interrupt output. Programmable to respond to the clock alarm, the watchdog timer, and the power monitor. Also programmable to either active HIGH (push or pull) or LOW (open drain).
V <sub>SS</sub>	Ground	Ground for the device. Must be connected to the ground of the system.
V <sub>CC</sub>	Power supply	Power supply inputs to the device. 3.0 V +20%, -10%
HSB	Input/Output	Hardware STORE Busy (HSB). When LOW this output indicates that a Hardware STORE is in progress. When pulled LOW external to the chip it initiates a nonvolatile STORE operation. After each Hardware and Software STORE operation HSB is driven HIGH for short time (t <sub>HHHD</sub> ) with standard output high current and then weak internal pull-up resistor keeps this pin HIGH (External pull-up resistor connection optional).
V <sub>CAP</sub>	Power supply	AutoStore capacitor. Supplies power to the nvSRAM during power loss to store data from SRAM to nonvolatile elements.

Note
8. Left unconnected if RTC feature is not used.



### **Device Operation**

The CY14B101KA/CY14B101MA nvSRAM is made up of two functional components paired in the same physical cell. These are a SRAM memory cell and a nonvolatile QuantumTrap cell. The SRAM memory cell operates as a standard fast static RAM. Data in the SRAM is transferred to the nonvolatile cell (the STORE operation), or from the nonvolatile cell to the SRAM (the RECALL operation). Using this unique architecture, all cells are stored and recalled in parallel. During the STORE and RECALL operations SRAM read and write operations are inhibited. The CY14B101KA/CY14B101MA supports infinite reads and writes similar to a typical SRAM. In addition, it provides infinite RECALL operations from the nonvolatile cells and up to 1 million STORE operations. See Truth Table For SRAM Operations on page 25 for a complete description of read and write modes.

#### **SRAM Read**

The CY14B101KA/CY14B101MA performs a read cycle whenever  $\overline{\text{CE}}$  and  $\overline{\text{OE}}$  are LOW, and  $\overline{\text{WE}}$  and  $\overline{\text{HSB}}$  are HIGH. The address specified on pins  $A_{0-16}$  or  $A_{0-15}$  determines which of the 131,072 data bytes or 65,536 words of 16 bits each are accessed. Byte enables (BHE, BLE) determine which bytes are enabled to the output, in the case of 16-bit words. When the read is initiated by an address transition, the outputs are valid after a delay of  $t_{AA}$  (read cycle #1). If the read is initiated by  $\overline{\text{CE}}$  or  $\overline{\text{OE}}$ , the outputs are valid at  $t_{ACE}$  or at  $t_{DOE}$ , whichever is later (read cycle #2). The data output repeatedly responds to address changes within the  $t_{AA}$  access time without the need for transitions on any control input pins. This remains valid until another address change or until  $\overline{\text{CE}}$  or  $\overline{\text{OE}}$  is brought HIGH, or  $\overline{\text{WE}}$  or  $\overline{\text{HSB}}$  is brought LOW.

#### **SRAM Write**

A write cycle is performed when  $\overline{\text{CE}}$  and  $\overline{\text{WE}}$  are LOW and  $\overline{\text{HSB}}$  is HIGH. The address inputs must be stable before entering the write cycle and must remain stable until  $\overline{\text{CE}}$  or  $\overline{\text{WE}}$  goes HIGH at the end of the cycle. The data on the common I/O pins IO $_{0-7}$  are written into the memory if it is valid  $t_{\text{SD}}$  before the end of a  $\overline{\text{WE}}$ -controlled write, or before the end of an  $\overline{\text{CE}}$ -controlled write. The Byte Enable inputs ( $\overline{\text{BHE}}$ ,  $\overline{\text{BLE}}$ ) determine which bytes are written, in the case of 16-bit words. It is recommended that  $\overline{\text{OE}}$  be kept HIGH during the entire write cycle to avoid data bus contention on common I/O lines. If  $\overline{\text{OE}}$  is left LOW, internal circuitry turns off the output buffers  $t_{\text{HZWE}}$  after WE goes LOW.

#### **AutoStore Operation**

The CY14B101KA/CY14B101MA stores data to the nvSRAM using one of three storage operations. <u>These</u> three operations are: Hardware STORE, activated by the HSB; Software STORE, activated by an address sequence; AutoStore, on device power-down. The AutoStore operation is a unique feature of QuantumTrap technology and is enabled by default on the CY14B101KA/CY14B101MA.

During a normal operation, the device draws current from  $V_{CC}$  to charge a capacitor connected to the  $V_{CAP}$  pin. This stored charge is used by the chip to perform a single STORE operation. If the voltage on the  $V_{CC}$  pin drops below  $V_{SWITCH}$ , the part

automatically disconnects the  $V_{CAP}$  pin from  $V_{CC}$ . A STORE operation is initiated with power provided by the  $V_{CAP}$  capacitor.

**Note** If the capacitor is not connected to  $V_{CAP}$  pin, AutoStore must be disabled using the soft sequence specified in Preventing AutoStore on page 7. In case AutoStore is enabled without a capacitor on  $V_{CAP}$  pin, the device attempts an AutoStore operation without sufficient charge to complete the Store. This corrupts the data stored in nvSRAM.

Figure 2. AutoStore Mode

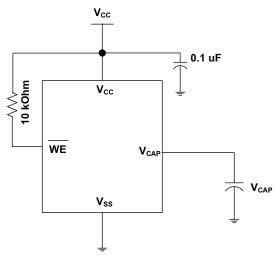


Figure 2 shows the proper connection of the storage capacitor ( $V_{CAP}$ ) for automatic STORE operation. See DC Electrical Characteristics on page 16 for the size of the  $V_{CAP}$ . The voltage on the  $V_{CAP}$  pin is driven to  $V_{CC}$  by a regulator on the chip. A pull-up should be placed on WE to hold it inactive during power-up. This pull-up is only effective if the WE signal is tristate during power-up. Many MPUs tristate their controls on power-up. This should be verified when using the pull-up. When the nvSRAM comes out of power-on-RECALL, the MPU must be active or the WE held inactive until the MPU comes out of reset.

To reduce unnecessary nonvolatile stores, AutoStore and Hardware STORE operations are ignored unless at least one write operation has taken place since the most recent STORE or RECALL cycle. Software initiated STORE cycles are performed regardless of whether a write operation has taken place.

The HSB signal is monitored by the system to detect if an AutoStore cycle is in progress.

### Hardware STORE (HSB) Operation

The CY14B101KA/CY14B101MA provides the  $\overline{HSB}$  pin to control and acknowledge the STORE operations. The  $\underline{HSB}$  pin is used to request a Hardware STORE cycle. When the HSB pin is driven LOW, the CY14B101KA/CY14B101MA conditionally initiates a STORE operation after t<sub>DELAY</sub>. An actual STORE cycle begins only if a write to the SRAM has taken place since the last STORE or RECALL cycle. The  $\overline{HSB}$  pin also acts as an open drain driver (internal 100 k $\Omega$  weak pull-up resistor) that is internally driven LOW to indicate a busy condition when the STORE (initiated by any means) is in progress.

**Note** After each Hardware and Software STORE operation HSB is driven HIGH for a short time (t<sub>HHHD</sub>) with standard output high



current and then remains HIGH by internal 100  $k\Omega$  pull-up resistor.

SRAM write operations that are in progress when HSB is driven LOW by any means are given time (t<sub>DELAY</sub>) to complete before the STORE operation <u>is initiated</u>. However, any SRAM <u>write</u> cycles requested after HSB goes LOW are in<u>hibited</u> until HSB returns HIGH. In case the write latch is not set, HSB is not driven LOW by the CY14B101KA/CY14B101MA. But any SRAM read and write cycles are inhibited until HSB is returned HIGH by MPU or other external source.

During any STORE operation, regardless of how it is initiated, the CY14B101KA/CY14B101MA continues to drive the HSB pin LOW, releasing it only when the STORE is complete. Upon completion of the STORE operation, the nvSRAM memory access is inhibited for t<sub>LZHSB</sub> time after HSB pin returns HIGH. Leave the HSB unconnected if it is not used.

#### **Hardware RECALL (Power-Up)**

During power-up or after any low power condition ( $V_{CC}$ <  $V_{SWITCH}$ ), an internal RECALL request is latched. When  $V_{CC}$  again exceeds the  $V_{SWITCH}$  on power-up, a RECALL cycle is automatically initiated and takes  $t_{HRECALL}$  to complete. During this time, the HSB pin is driven LOW by the HSB driver and all reads and writes to nvSRAM are inhibited.

#### **Software STORE**

Data is transferred from the SRAM to the nonvolatile memory by a software address sequence. The CY14B101KA/CY14B101MA Software STORE cycle is initiated by executing sequential  $\overline{\text{CE}}$  or  $\overline{\text{OE}}$  controlled read cycles from six specific address locations in exact order. During the STORE cycle, an erase of the previous nonvolatile data is first performed, followed by a program of the nonvolatile elements. After a STORE cycle is initiated, further input and output are disabled until the cycle is completed.

Because a sequence of reads from specific addresses is used for STORE initiation, it is important that no other read or write accesses intervene in the sequence, or the sequence is aborted and no STORE or RECALL takes place. To initiate the Software STORE cycle, the following read sequence must be performed:

- 1. Read address 0x4E38 Valid READ
- 2. Read address 0xB1C7 Valid READ
- 3. Read address 0x83E0 Valid READ
- 4. Read address 0x7C1F Valid READ
- Read address 0x703F Valid READ
- 6. Read address 0x8FC0 Initiate STORE cycle

The software sequence may be clocked with  $\overline{\text{CE}}$  controlled reads or  $\overline{\text{OE}}$  controlled reads, with  $\overline{\text{WE}}$  kept HIGH for all the six READ sequences. After the sixth address in the sequence is entered, the STORE cycle commences and the chip is disabled.  $\overline{\text{HSB}}$  is driven LOW. After the t<sub>STORE</sub> cycle time is fulfilled, the SRAM is activated again for the read and write operation.

#### **Software RECALL**

Data is transferred from the nonvolatile memory to the SRAM by a software address sequence. A Software RECALL cycle is initiated with a sequence of read operations in a manner similar to the Software STORE initiation. To initiate the RECALL cycle, the following sequence of  $\overline{\text{CE}}$  or  $\overline{\text{OE}}$  controlled read operations must be performed:

- 1. Read address 0x4E38 Valid READ
- 2. Read address 0xB1C7 Valid READ
- 3. Read address 0x83E0 Valid READ
- 4. Read address 0x7C1F Valid READ
- Read address 0x703F Valid READ
- 6. Read address 0x4C63 Initiate RECALL cycle

Internally, RECALL is a two step procedure. First, the SRAM data is cleared. Next, the nonvolatile information is transferred into the SRAM cells. After the  $t_{RECALL}$  cycle time, the SRAM is again ready for read and write operations. The RECALL operation does not alter the data in the nonvolatile elements.



**Table 1. Mode Selection** 

CE	WE	OE	BHE, BLE <sup>[9]</sup>	$A_{15}^{-}A_0^{[10]}$	Mode	1/0	Power
Н	X	X	X	Х	Not selected	Output high Z	Standby
L	Н	L	L	Х	Read SRAM	Output data	Active
L	L	X	L	Х	Write SRAM	Input data	Active
L	Н	L	X	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x8B45	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM AutoStore Disable	Output data	Active <sup>[11]</sup>
L	Н	L	X	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x4B46	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM AutoStore Enable	Output data	Active <sup>[11]</sup>
L	Н	L	X	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x8FC0	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM Nonvolatile STORE	Output data Output data Output data Output data Output data Output data Output high Z	Active I <sub>CC2</sub> <sup>[11]</sup>
L	Н	L	Х	0x4E38 0xB1C7 0x83E0 0x7C1F 0x703F 0x4C63	Read SRAM Read SRAM Read SRAM Read SRAM Read SRAM Nonvolatile RECALL	Output data Output data Output data Output data Output data Output data Output high Z	Active <sup>[11]</sup>

#### **Preventing AutoStore**

The AutoStore function is disabled by initiating an AutoStore disable sequence. A sequence of read operations is performed in a manner similar to the Software STORE initiation. To initiate the AutoStore disable sequence, the following sequence of CE or OE controlled read operations must be performed:

- 1. Read address 0x4E38 Valid READ
- 2. Read address 0xB1C7 Valid READ
- 3. Read address 0x83E0 Valid READ
- 4. Read address 0x7C1F Valid READ
- 5. Read address 0x703F Valid READ
- 6. Read address 0x8B45 AutoStore Disable

The AutoStore is re-enabled by initiating an AutoStore enable sequence. A sequence of read operations is performed in a manner similar to the Software RECALL initiation.

To initiate the AutoStore enable sequence, the following sequence of CE or OE controlled read operations must be performed:

- 1. Read address 0x4E38 Valid READ
- 2. Read address 0xB1C7 Valid READ
- 3. Read address 0x83E0 Valid READ
- 4. Read address 0x7C1F Valid READ
- 5. Read address 0x703F Valid READ
- 6. Read address 0x4B46 AutoStore Enable

If the AutoStore function is disabled or re-enabled, a manual STORE operation (Hardware or Software) issued to save the AutoStore state through subsequent power-down cycles. The part comes from the factory with AutoStore enabled and 0x00 written in all cells.

- 9. BHE and BLE are applicable for x 16 configuration only.
- 10. While there are 17 address lines on the CY14B101KA (16 address lines on the CY14B101MA), only the 13 address lines (A<sub>14</sub>—A<sub>2</sub>) are used to control software modes. The remaining address lines are don't care.
- 11. The six consecutive address locations must be in the order listed. WE must be HIGH during all six cycles to enable a nonvolatile cycle.



#### **Data Protection**

The CY14B101KA/CY14B101MA protects data from corruption during low voltage conditions by inhibiting all externally initiated STORE and write operations. The low voltage condition is detected when  $V_{CC}$  is less than  $V_{SWITCH}$ . If the CY14B101KA/CY14B101MA is in a write mode (both CE and WE are LOW) at power-up, after a RECALL or STORE, the write is inhibited until the SRAM is enabled after  $t_{LZHSB}$  (HSB to output active). This protects against inadvertent writes during power-up or brown out conditions.

#### **Noise Considerations**

See CY application note AN1064.

### Real Time Clock Operation

#### nvTIME Operation

The CY14B101KA/CY14B101MA offers internal registers that contain clock, alarm, watchdog, interrupt, and control functions. RTC registers use the last 16 address locations of the SRAM. Internal double buffering of the clock and timer information registers prevents accessing transitional internal clock data during a read or write operation. Double buffering also circumvents disrupting normal timing counts or the clock accuracy of the internal clock when accessing clock data. Clock and alarm registers store data in BCD format.

RTC functionality is described with respect to CY14B101KA in the following sections. The same description applies to CY14B101MA, except for the RTC register addresses. The RTC register addresses for CY14B101KA range from 0x1FFF0 to 0x1FFFF, while those for CY14B101MA range from 0x0FFF0 to 0x0FFFF. See Table 3 on page 12 and Table 4 on page 13 for a detailed Register Map description.

#### **Clock Operations**

The clock registers maintain time up to 9,999 years in one-second increments. The time can be set to any calendar time and the clock automatically keeps track of days of the week and month, leap years, and century transitions. There are eight registers dedicated to the clock functions, which are used to set time with a write cycle and to read time with a read cycle. These registers contain the time of day in BCD format. Bits defined as '0' are currently not used and are reserved for future use by Cypress.

#### Reading the Clock

The double buffered RTC register structure reduces the chance of reading incorrect data from the clock. Internal updates to the CY14B101KA time keeping registers are stopped when the read bit 'R' (in the flags register at 0x1FFF0) is set to '1' before reading clock data to prevent reading of data in transition. Stopping the register updates does not affect clock accuracy.

When a read sequence of RTC device is initiated, the update of the user timekeeping registers stops and does not restart until a '0' is written to the read bit 'R' (in the flags register at 0x1FFF0). After the end of read sequence, all the RTC registers are simultaneously updated within 20 ms.

#### **Setting the Clock**

A write access to the RTC device stops updates to the time keeping registers and enables the time to be set when the write bit 'W' (in the flags register at 0x1FFF0) is set to '1'. The correct day, date, and time is then written into the registers and must be in 24 hour BCD format. The time written is referred to as the "Base Time". This value is stored in nonvolatile registers and used in the calculation of the current time. When the write bit 'W' is cleared by writing '0' to it, the values of timekeeping registers are transferred to the actual clock counters after which the clock resumes normal operation.

If the time written to the timekeeping registers is not in the correct BCD format, each invalid nibble of the RTC registers continue counting to 0xF before rolling over to 0x0 after which RTC resumes normal operation.

**Note** After 'W' bit is set to '0', values written into the timekeeping, alarm, calibration, and interrupt registers are transferred to the RTC time keeping counters in  $t_{RTCp}$  time. These counter values must be saved to nonvolatile memory either by initiating a Software/Hardware STORE or AutoStore operation. While working in AutoStore disabled mode, perform a STORE operation after  $t_{RTCp}$  time while writing into the RTC registers for the modifications to be correctly recorded.

#### **Backup Power**

The RTC in the CY14B101KA is intended for permanently powered operation. The  $V_{RTCcap}$  or  $V_{RTCbat}$  pin is connected depending on whether a capacitor or battery is chosen for the application. When the primary power,  $V_{CC}$ , fails and drops below  $V_{SWITCH}$  the device switches to the backup power supply.

The clock oscillator uses very little current, which maximizes the backup time available from the backup source. Regardless of the clock operation with the primary source removed, the data stored in the nvSRAM is secure, having been stored in the nonvolatile elements when power was lost.

During backup operation, the CY14B101KA consumes a 0.35  $\mu$ A (Typ) at room temperature. The user must choose capacitor or battery values according to the application.

Backup time values based on maximum current specifications are shown in the following Table 2. Nominal backup times are approximately two times longer.

Table 2. RTC Backup Time

Capacitor Value	Backup Time
0.1 F	72 hours
0.47 F	14 days
1.0 F	30 days

Using a capacitor has the obvious advantage of recharging the backup source each time the system is powered up. If a battery is used, a 3 V lithium is recommended and the CY14B101KA sources current only from the battery when the primary power is removed. However, the battery is not recharged at any time by the CY14B101KA. The battery capacity must be chosen for total anticipated cumulative down time required over the life of the system.



#### Stopping and Starting the Oscillator

The OSCEN bit in the calibration register at 0x1FFF8 controls the enable and disable of the oscillator. This bit is nonvolatile and is shipped to customers in the "enabled" (set to '0') state. To preserve the battery life when the system is in storage, OSCEN must be set to '1'. This turns off the oscillator circuit, extending the battery life. If the OSCEN bit goes from disabled to enabled, it takes approximately one second (two seconds maximum) for the oscillator to start.

While system power is off, if the voltage on the backup supply  $(V_{RTCcap} \ or \ V_{RTCbat})$  falls below their respective minimum level, the oscillator may fail. The CY14B101KA has the ability to detect oscillator failure when system power is restored. This is recorded in the Oscillator Fail Flag (OSCF) of the flags register at the address 0x1FFF0. When the device is powered on  $(V_{CC}$  goes above  $V_{SWITCH})$  the OSCEN bit is checked for the 'enabled' status. If the OSCEN bit is enabled and the oscillator is not active within the first 5 ms, the OSCF bit is set to '1'. The system must check for this condition and then write '0' to clear the flag.

Note that in addition to setting the OSCF flag bit, the time registers are reset to the 'Base Time', which is the value last written to the timekeeping registers. The control or calibration registers and the OSCEN bit are not affected by the 'oscillator failed' condition.

The value of OSCF must be reset to '0' when the time registers are written for the first time. This initializes the state of this bit which may have become set when the system was first powered on.

To reset OSCF, set the write bit 'W' (in the flags register at 0x1FFF0) to a '1' to enable writes to the flags register . Write a '0' to the OSCF bit and then reset the write bit to '0' to disable writes.

#### Calibrating the Clock

The RTC is driven by a quartz controlled crystal with a nominal frequency of 32.768 kHz. Clock accuracy depends on the quality of the crystal and calibration. The crystals available in market typically have an error of  $\pm 20$  ppm to  $\pm 35$  ppm. However, CY14B101KA employs a calibration circuit that improves the accuracy to  $\pm 1/-2$  ppm at 25 °C. This implies an error of  $\pm 2.5$  seconds to  $\pm 3.5$  seconds per month.

The calibration circuit adds or subtracts counts from the oscillator divider circuit to achieve this accuracy. The number of pulses that are suppressed (subtracted, negative calibration) or split (added, positive calibration) depends upon the value loaded into the five calibration bits found in Calibration register at 0x1FFF8. The calibration bits occupy the five lower order bits in the Calibration register. These bits are set to represent any value between '0' and 31 in binary form. Bit D5 is a sign bit, where a '1' indicates positive calibration and a '0' indicates negative calibration. Adding counts speeds the clock up and subtracting counts slows the clock down. If a binary '1' is loaded into the register, it corresponds to an adjustment of 4.068 or -2.034 ppm offset in oscillator error, depending on the sign.

Calibration occurs within a 64-minute cycle. The first 62 minutes in the cycle may, once every minute, have one second shortened by 128 or lengthened by 256 oscillator cycles. If a binary '1' is loaded into the register, only the first two minutes of the 64-minute cycle are modified. If a binary 6 is loaded, the first 12

are affected, and so on. Therefore, each calibration step has the effect of adding 512 or subtracting 256 oscillator cycles for every 125,829,120 actual oscillator cycles, that is, 4.068 or –2.034 ppm of adjustment per calibration step in the Calibration register.

To determine the required calibration, the CAL bit in the flags register (0x1FFF0) must be set to '1'. This causes the INT pin to toggle at a nominal frequency of 512 Hz. Any deviation measured from the 512 Hz indicates the degree and direction of the required correction. For example, a reading of 512.01024 Hz indicates a +20 ppm error. Hence, a decimal value of -10 (001010b) must be loaded into the Calibration register to offset this error.

**Note** Setting or changing the Calibration register does not affect the test output frequency.

To set or clear CAL, set the write bit 'W' (in the flags register at 0x1FFF0) to '1' to enable writes to the flags register. Write a value to CAL, and then reset the write bit to '0' to disable writes.

#### **Alarm**

The alarm function compares user programmed values of alarm time and date (stored in the registers 0x1FFF1-5) with the corresponding time of day and date values. When a match occurs, the alarm internal flag (AF) is set and an interrupt is generated on INT pin if Alarm Interrupt Enable (AIE) bit is set.

There are four alarm match fields – date, hours, minutes, and seconds. Each of these fields has a match bit that is used to determine if the field is used in the alarm match logic. Setting the match bit to '0' indicates that the corresponding field is used in the match process. Depending on the match bits, the alarm occurs as specifically as once a month or as frequently as once every minute. Selecting none of the match bits (all 1s) indicates that no match is required and therefore, alarm is disabled. Selecting all match bits (all 0s) causes an exact time and date

There are two ways to detect an alarm event: by reading the AF flag or monitoring the INT pin. The AF flag in the flags register at 0x1FFF0 indicates that a date or time match has occurred. The AF bit is set to '1' when a match occurs. Reading the flags register clears the alarm flag bit (and all others). A hardware interrupt pin may also be used to detect an alarm event.

To set, clear or enable an alarm, set the 'W' bit (in flags register – 0x1FFF0) to '1' to enable writes to Alarm Registers. After writing the alarm value, clear the 'W' bit back to '0' for the changes to take effect.

**Note** CY14B101KA requires the alarm match bit for seconds (bit 'D7' in Alarm-Seconds register 0x1FFF2) to be set to '0' for proper operation of Alarm Flag and Interrupt.

#### **Watchdog Timer**

The watchdog timer is a free running down counter that uses the 32 Hz clock (31.25 ms) derived from the crystal oscillator. The oscillator must be running for the watchdog to function. It begins counting down from the value loaded in the watchdog timer register.

The timer consists of a loadable register and a free running counter. On power-up, the watchdog time out value in register 0x1FFF7 is loaded into the counter load register. Counting begins on power-up and restarts from the loadable value any time the watchdog strobe (WDS) bit is set to '1'. The counter is

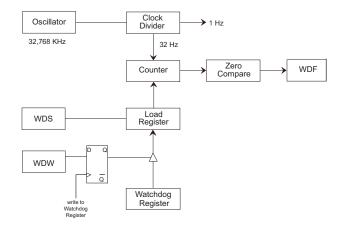


compared to the terminal value of '0'. If the counter reaches this value, it causes an internal flag and an optional interrupt output. You can prevent the time out interrupt by setting WDS bit to '1' prior to the counter reaching '0'. This causes the counter to reload with the watchdog time out value and to be restarted. As long as the user sets the WDS bit prior to the counter reaching the terminal value, the interrupt and WDT flag never occur.

New time out values are written by setting the watchdog write bit to '0'. When the WDW is '0', new writes to the watchdog time out value bits D5–D0 are enabled to modify the time out value. When WDW is '1', writes to bits D5-D0 are ignored. The WDW function enables a user to set the WDS bit without concern that the watchdog timer value is modified. A logical diagram of the watchdog timer is shown in Figure 3. Note that setting the watchdog time out value to '0' disables the watchdog function.

The output of the watchdog timer is the flag bit WDF that is set if the watchdog is allowed to time out. If the watchdog interrupt enable (WIE) bit in the interrupt register is set, a hardware interrupt on INT pin is also generated on watchdog timeout. The flag and the hardware interrupt are both cleared when the user reads the flags registers.

Figure 3. Watchdog Timer Block Diagram



#### **Power Monitor**

The CY14B101KA provides a power management scheme with power fail interrupt capability. It also controls the internal switch to backup power for the clock and protects the memory from low  $V_{CC}$  access. The power monitor is based on an internal bandgap reference circuit that compares the  $V_{CC}$  voltage to  $V_{SWITCH}$  threshold.

As described in the AutoStore Operation on page 5, when  $V_{SWITCH}$  is reached as  $V_{CC}$  decays from power loss, a data STORE operation is initiated from SRAM to the nonvolatile elements, securing the last SRAM data state. Power is also switched from  $V_{CC}$  to the backup supply (battery or capacitor) to operate the RTC oscillator.

When operating from the backup source, read and write operations to nvSRAM are inhibited and the RTC functions are not available to the user. The RTC clock continues to operate in the background. The updated RTC time keeping registers data are available to the user after  $\rm V_{CC}$  is restored to the device (see AutoStore/Power-Up RECALL on page 22).

#### Interrupts

The CY14B101KA has flags register, interrupt register, and interrupt logic that can signal interrupt to the microcontroller. There are three potential sources for interrupt: watchdog timer, power monitor, and alarm timer. Each of these can be individually enabled to drive the INT pin by appropriate setting in the Interrupt register (0x1FFF6). In addition, each has an associated flag bit in the flags register (0x1FFF0) that the host processor uses to determine the cause of the interrupt. The INT pin driver has two bits that specify its behavior when an interrupt occurs.

An interrupt is raised only if both a flag is raised by one of the three sources and the respective interrupt enable bit in interrupts register is enabled (set to '1'). After an interrupt source is active, two programmable bits, H/L and P/L, determine the behavior of the output pin driver on INT pin. These two bits are located in the interrupt register and can be used to drive level or pulse mode output from the INT pin. In pulse mode, the pulse width is internally fixed at approximately 200 ms. This mode is intended to reset a host microcontroller. In the level mode, the pin goes to its active polarity until the flags register is read by the user. This mode is used as an interrupt to a host microcontroller. The control bits are summarized in the following section.

Interrupts are only generated while working on normal power and are not triggered when system is running in backup power mode.

**Note** CY14B101KA generates valid interrupts only after the Power-up RECALL sequence is completed. All events on INT pin must be ignored for  $t_{HRECALL}$  duration after power-up.

#### Interrupt Register

Watchdog Interrupt Enable (WIE). When set to '1', the watchdog timer drives the INT pin and an internal flag when a watchdog time out occurs. When WIE is set to '0', the watchdog timer only affects the WDF flag in Flags register.

**Alarm Interrupt Enable (AIE).** When set to '1', the alarm match drives the INT pin and an internal flag. When AIE is set to '0', the alarm match only affects the AF flag in Flags register.

**Power Fail Interrupt Enable (PFE).** When set to '1', the power fail monitor drives the pin and an internal flag. When PFE is set to '0', the power fail monitor only affects the PF flag in flags register.

**High/Low (H/L).** When set to a '1', the INT pin is active HIGH and the driver mode is push pull. The INT pin drives HIGH only when  $V_{CC}$  is greater than  $V_{SWITCH}$ . When set to a '0', the INT pin is active LOW and the drive mode is open drain. The INT pin must be pulled up to Vcc by a 10 k resistor while using the interrupt in active LOW mode.

**Pulse/Level (P/L).** When set to a '1' and an interrupt occurs, the INT pin is driven for approximately 200 ms. When P/L is set to a '0', the INT pin is driven HIGH or LOW (determined by H/L) until the flags register is read.

When an enabled interrupt source activates the INT pin, an external host reads the flags registers to determine the cause. All flags are cleared when the register is read. If the INT pin is programmed for level mode, then the condition clears and the INT pin returns to its inactive state. If the pin is programmed for pulse mode, then reading the flag also clears the flag and the pin. The pulse does not complete its specified duration if the flags register is read. If the INT pin is used as a host reset, then the flags register is not read during a reset.

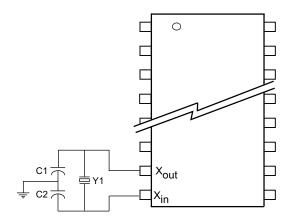


#### Flags Register

The flags register has three flag bits: WDF, AF, and PF, which can be used to generate an interrupt. These flags are set by the watchdog timeout, alarm match, or power fail monitor respectively. The processor can either poll this register or enable interrupts to be informed when a flag is set. These flags are

automatically reset when the register is read. The flags register is automatically loaded with the value 0x00 on power-up (except for the OSCF bit; see Stopping and Starting the Oscillator on page 9).

Figure 4. RTC Recommended Component Configuration [12]

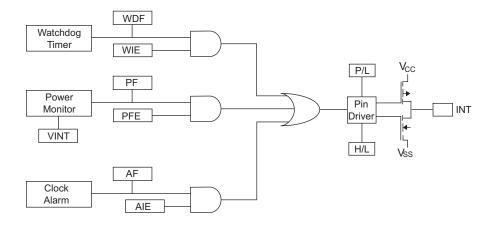


#### **Recommended Values**

 $Y_1 = 32.768 \text{ kHz } (12.5 \text{ pF})$   $C_1 = 10 \text{ pF}$  $C_2 = 67 \text{ pF}$ 

**Note:** The recommended values for C1 and C2 include board trace capacitance.

Figure 5. Interrupt Block Diagram



WDF - Watchdog Timer Flag

WIE - Watchdog Interrupt

Enable

PF - Power Fail Flag

PFE - Power Fail Enable

AF - Alarm Flag

AIE - Alarm Interrupt Enable

P/L - Pulse Level

H/L - High/Low

#### Note

<sup>12.</sup> For nonvolatile static random access memory (nvSRAM) real time clock (RTC) design guidelines and best practices, see application note AN61546.



Table 3. RTC Register Map [13, 14, 15]

Reg	Register				BCD Forma	it Data <sup>[14]</sup>				Function/Dongs
CY14B101KA	CY14B101MA	D7	D6	D5	D4	D3	D2	D1	D0	- Function/Range
0x1FFFF	0x0FFFF		10s	years	•		Ye	ears		Years: 00-99
0x1FFFE	0x0FFFE	0	0	0	10s months		Мс	onths		Months: 01-12
0x1FFFD	0x0FFFD	0	0	10s da	ay of month		Day o	f month		Day of month: 01-31
0x1FFFC	0x0FFFC	0	0	0	0	0		Day of w	reek	Day of week: 01-07
0x1FFFB	0x0FFFB	0	0	10	s hours		Н	ours		Hours: 00-23
0x1FFFA	0x0FFFA	0		10s min	utes		Mir	nutes		Minutes: 00–59
0x1FFF9	0x0FFF9	0	10s seconds		nds Seconds			Seconds: 00-59		
0x1FFF8	0x0FFF8	OSCEN (0)	0	Cal sign (0)		Calibration (00000)			Calibration values [16]	
0x1FFF7	0x0FFF7	WDS (0)	WDW (0)			WDT (00	0000)			Watchdog <sup>[16]</sup>
0x1FFF6	0x0FFF6	WIE (0)	AIE (0)	PFE (0)	0	H/L (1)	P/L (0)	0	0	Interrupts [16]
0x1FFF5	0x0FFF5	M (1)	0	10s alarm date			Alar	m day		Alarm, day of month: 01-31
0x1FFF4	0x0FFF4	M (1)	0	10s a	larm hours		Alarn	n hours		Alarm, hours: 00-23
0x1FFF3	0x0FFF3	M (1)	10s	alarm	minutes		Alarm	minutes	3	Alarm, minutes: 00-59
0x1FFF2	0x0FFF2	M (1)	10s	alarm s	seconds		Alarm,	second	S	Alarm, seconds: 00-59
0x1FFF1	0x0FFF1		10s ce	nturies	Centuries				Centuries: 00-99	
0x1FFF0	0x0FFF0	WDF	AF	PF	OSCF <sup>[17]</sup>	0	CAL (0)	W (0)	R (0)	Flags <sup>[16]</sup>

<sup>13.</sup> Upper byte D15—D8 (CY14B101MA) of RTC registers are reserved for future use.

14. The unused bits of RTC registers are reserved for future use and should be set to '0'.

15. () designates values shipped from the factory.

16. This is a binary value, not a BCD value.

17. When user resets OSCF flag bit, the flags register will be updated after t<sub>RTCp</sub> time.



Table 4. Register Map Detail

	ister				Descri	ntion				
CY14B101KA	CY14B101MA	- Description								
0x1FFFF	0x0FFFF				Time Keepii	ng - Years				
OXIIIII OXOIIII	UXUFFFF	D7	D6	D5	D4	D3	D2	D1	D0	
			10s	years			Ye	ears		
		upper nibb		contains the	f the year. Low value for 10s					
0.45555	0.05555	Time Keeping - Months								
0x1FFFE	0x0FFFE	D7	D6	D5	D4	D3	D2	D1	D0	
	l	0	0	0	10s month		Мо	onths		
		from 0 to 9		ole (one bit)	h. Lower nibble contains the u	pper digit a				
0x1FFFD	0x0FFFD				Time Keepi	ng - Date				
OXIIIID	OXOTTE	D7	D6	D5	D4	D3	D2	D1	D0	
		0	0	10s day	of month		Day o	of month		
		and operat	tes from 0 to	9; upper nib	e of the month. bble (two bits) Leap years ar	contains the	e 10s digit a	nd operates		
0x1FFFC	0x0FFFC	Time Keeping - Day								
OXIIIIO	UXUFFFC	D7	D6	D5	D4	D3	D2	D1	D0	
		0	0	0	0	0		Day of wee	k	
		a ring cour	nter that cou	nts from 1 to	a value that co 7 then returns trated with the	to 1. The u date.				
0x1FFFB	0x0FFFB				Time Keepir	ng - Hours				
OXIIIIB	OXOTTE	D7	D6	D5	D4	D3	D2	D1	D0	
		0	0	10s	hours		H	ours		
		digit and o	perates from		n 24 hour forner nibble (two l 0–23.					
0x1FFFA	0x0FFFA				Time Keeping	g - Minutes	;			
VAIITIA	OXOLLIA	D7	D6	D5	D4	D3	D2	D1	D0	
		0		10s minutes	S		Mir	nutes		
		from 0 to 9	he BCD valu ); upper nibb for the regis	ole (three bit	. Lower nibble s) contains the	(four bits) o upper min	ontains the utes digit a	lower digit a nd operates	nd operatifrom 0 to	
0×1555	0.05550				Time Keeping	g - Seconds	3			
0x1FFF9	0x0FFF9	D7	D6	D5	D4	D3	D2	D1	D0	
	ı	0		10s second	S		Sed	conds		
		from 0 to 9	ne BCD valu ; upper nibb ister is 0–59	le (three bits	s. Lower nibble ) contains the	(four bits) o upper digit	contains the and operate	lower digit a es from 0 to 5	nd operat 5. The ran	



Table 4. Register Map Detail (continued)

Reg	ister				D	ntion			
CY14B101KA	CY14B101MA	Description							
0×45550	0.05550				Calibration	n/Control			
0x1FFF8	0x0FFF8	D7	D6	D5	D4	D3	D2	D1	D0
		OSCEN	0	Calibration sign			Calibration	•	
OSC	CEN			en set to '1', to saves batter					cillator run
Calibrat	ion Sign	Determine from the ti		ration adjust	ment is appli	ed as an ac	ldition (1) to	or as a su	btraction (
Calibration These five bits control the calibration of the clock.									
0v1EEE7	0×05557				WatchDo	g Timer			
0x1FFF7	0x0FFF7	D7	D6	D5	D4	D3	D2	D1	D0
	1	WDS	WDW			WE	T		1
W	DS	'0' has no	effect. The b	ing this bit to bit is cleared a t always retu	automatically				
W	DW	(D5–D0). Setting this	This allows the bit to '0' all	e. Setting this ne user to set ows bits D5–l s function is e	the watchdog 00 to be writt	g strobe bit ven to the wa	without distu atchdog regi	urbing the tir ster when th	meout value he next writ
W	DT	register. It 31.25 ms	represents a	ection. The ware a multiplier of 1) to 2 secon se bits can be	the 32 Hz o	ount (31.25 f 3 Fh). Sett	ms). The ra	ange of time chdog timer	eout value i register to
0×4555	0.05550			I	nterrupt Sta	tus/Contro			
0x1FFF6	0x0FFF6	D7	D6	D5	D4	D3	D2	D1	D0
		WIE	AIE	PFE	0	H/L	P/L	0	0
W	ΙΕ	Watchdog interrupt enable. When set to '1' and a watchdog timeout occurs, the watchdog time drives the INT pin and the WDF flag. When set to '0', the watchdog timeout affects only the WDF flag.							
A	IE	Alarm interrupt enable. When set to '1', the alarm match drives the INT pin and the AF flag. Whe set to '0', the alarm match only affects the AF flag.							
Pl	E	Power fail enable. When set to '1', the power fail monitor drives the INT pin and the PF flag. When set to '0', the power fail monitor affects only the PF flag.							
(	)	Reserved	for future us	е					
Н	/L	High/Low. drain, activ		'1', the INT p	in is driven a	ctive HIGH.	When set to	o '0', the IN	Γ pin is ope
P	/L	for approx		to '1', the INT ms. When se is read.	t to '0', the IN	IT pin is driv			
0x1FFF5	0x0FFF5				Alarm			1 -	
		D7	D6	D5	D4	D3	D2	D1	D0
		M Contains t value.	0 he alarm val	10s ala		h and the m		n date lect or dese	lect the dat
N	Л	Match. Wh		s set to '0', the uit to ignore th			e alarm ma	tch. Setting	this bit to '



Table 4. Register Map Detail (continued)

Reg	ister				Door	ntion					
CY14B101KA	CY14B101MA				Descri	ption					
0x1FFF4	0x0FFF4				Alarm -	Hours					
UXIFFF4	UXUFFF4	D7	D6	D5	D4	D3	D2	D1	D0		
		М	0	10s ala	rm hours		Alarm	hours			
		Contains t	he alarm val	ue for the ho	urs and the n	nask bit to s	elect or des	elect the ho	urs value.		
N	M				e hours value		ne alarm ma	tch. Setting	this bit to '1		
	1	causes the	e match circi	uit to ignore t	he hours valu						
0x1FFF3	0x0FFF3	<b>D</b> =	<b>D</b> 0	D.F.	Alarm - I		<b>D</b> 0	Centuries ne lower digit and ope to 9. The range for the  D2 D1  CAL W  Vatchdog timer is allow gs register is read or cate match the values s	- Do		
_		<b>D7</b>	D6	D5 Os alarm minu	D4	D3			D0		
						mook hit to			nutoo volus		
	M										
ľ	VI	'1' causes	the match c	ircuit to igno	e the minutes	ue is useu ii s value.	i ille alaitti i	maten. Setti	ng mis bit t		
					Alarm - S						
0x1FFF2	0x0FFF2	D7	D6	D5	D4	D3	D2	D1	D0		
		М	10	s alarm seco	nds		Alarm	seconds			
		Contains tl	ne alarm valu	ue for the sec	onds and the i	mask bit to s	elect or des	elect the sec	onds' value		
N	М	Match. When this bit is set to '0', the seconds value is used in the alarm match. Setting this bit to									
	i	'1' causes	the match c		re the second						
0x1FFF1	0x0FFF1				ime Keeping						
		D7	D6	D5 enturies	D4	D3			D0		
	T	to 9; uppe 0–99 cent	r nibble cont	ains the uppo	er digit and op	erates from	the lower d 0 to 9. The	range for th	rates from one register i		
0x1FFF0	0x0FFF0	<b>5-</b>	<b>D</b> 0	D.5	Flag		<b>D</b> 0		- Do		
		<b>D7</b> WDF	D6 AF	D5 PF	D4 OSCF	<b>D3</b>		D1 minutes elect the mir match. Settin  D1 seconds elect the seconds elect the seconds elect the seconds elect the second and oper range for the  D1 W mer is allow r is read or or the values series read or or the power factor in the interval of the second and it is read or or the power factor in the is read or or the power factor in the is read or or the power factor in the is read or or the power factor in the is read or or the power factor in the is read or or the power factor in the is read or or the power factor in the is read or or the power factor in the is read or or the power factor in the is read or or the power factor in the is read or or the power factor in the is read or or the power factor in the is read or or the power factor in the interval or or the interval or or the power factor in the interval or or the pow	D0 R		
W	DF	Watchdog	timer flag. T	his read only	/ bit is set to '	1' when the	watchdog t	imer is allov	ved to reacl		
Α	AF	0 without being reset by the user. It is cleared to 0 when the flags register is read or on power-up Alarm flag. This read only bit is set to '1' when the time and date match the values stored in the alarm registers with the match bits = 0. It is cleared when the flags register is read or on power-up									
P	PF	Power fail	flag. This re	ead only bit	s set to '1' w	hen power	falls below	the power fa			
OS	SCF	V <sub>SWITCH</sub> . It is cleared to 0 when the flags register is read or on power-up.  Oscillator fail flag. Set to '1' on power-up if the oscillator is enabled and not running in the firs 5 ms of operation. This indicates that RTC backup power failed and clock value is no longer valid This bit survives the power cycle and is never cleared internally by the chip. The user must check for this condition and write '0' to clear this flag. When user resets OSCF flag bit, the bit will be updated after t <sub>RTCp</sub> time.									
C	AL	Calibration mode. When set to '1', a 512 Hz square wave is output on the INT pin. When set to '0', the INT pin resumes normal operation. This bit defaults to '0' (disabled) on power-up.									
V	N	write to R <sup>-</sup> Setting the keeping co	C registers (W' bit to '(	, alarm regis o' causes the e time has cl	'1' freezes up ters, calibration contents of manged. This	on register, the RTC reg	interrupt reg gisters to be	gister and fla transferred	ags registed to the time		
I	₹	are not se	en during the	e reading pro	ops clock upd cess. Set 'R' quire 'W' bit to	bit to '0' to r	esume cloc	k updates to	the holding		



### **Maximum Ratings**

Exceeding maximum ratings may impair the useful life of the device. These user guidelines are not tested. Storage temperature ......-65 °C to +150 °C Maximum accumulated storage time At 150 °C ambient temperature ...... 1000 h At 85 °C ambient temperature ...... 20 Years Maximum junction temperature ...... 150 °C Supply voltage on  $V_{CC}$  relative to  $V_{SS}$  ......–0.5 V to 4.1 V Voltage applied to outputs in High Z state ......–0.5 V to  $V_{CC}$  + 0.5 V Input voltage ......–0.5 V to  $V_{CC}$  + 0.5 V

Transient voltage (< 20 ns) on any pin to ground potential–2.0 V to $V_{CC}$ + 2.0 V
Package power dissipation capability (T <sub>A</sub> = 25 °C)
Surface mount Pb soldering temperature (3 seconds)+260 °C
DC output current (1 output at a time, 1s duration) 15 mA
Static discharge voltage (per MIL-STD-883, Method 3015) > 2001 V
Latch up current > 200 mA

### **Operating Range**

Range	Ambient Temperature	V <sub>CC</sub>
Industrial	–40 °C to +85 °C	2.7 V to 3.6 V

### **DC Electrical Characteristics**

Over the Operating Range

Parameter	Description	Test Conditions	Min	<b>Typ</b> [18]	Max	Unit
V <sub>CC</sub>	Power supply voltage		2.7	3.0	3.6	V
I <sub>CC1</sub>	Average V <sub>cc</sub> current	t <sub>RC</sub> = 25 ns t <sub>RC</sub> = 45 ns Values obtained without output loads (I <sub>OUT</sub> = 0 mA)	_	_	70 52	mA mA
I <sub>CC2</sub>	Average V <sub>CC</sub> current during STORE	All inputs don't care, V <sub>CC</sub> = Max. Average current for duration t <sub>STORE</sub>	_	_	10	mA
I <sub>CC3</sub> <sup>[18]</sup>	Average V <sub>CC</sub> current at t <sub>RC</sub> = 200 ns, V <sub>CC(Typ)</sub> , 25 °C	All inputs cycling at CMOS levels. Values obtained without output loads (I <sub>OUT</sub> = 0 mA).	-	35	_	mA
I <sub>CC4</sub>	Average V <sub>CAP</sub> current during AutoStore cycle	All inputs don't care. Average current for duration t <sub>STORE</sub>	_	_	5	mA
I <sub>SB</sub>	V <sub>CC</sub> standby current	$\overline{\text{CE}} \ge (\text{V}_{\text{CC}} - 0.2  \text{V}).$ $\text{V}_{\text{IN}} \le 0.2  \text{V}  \text{or} \ge (\text{V}_{\text{CC}} - 0.2  \text{V}).$ W bit set to '0'. Standby current level after nonvolatile cycle is complete. Inputs are static. f = 0 MHz.	_	-	5	mA
I <sub>IX</sub> <sup>[19]</sup>	Input leakage current (except HSB)	$V_{CC} = Max, V_{SS} \le V_{IN} \le V_{CC}$	-1	_	+1	μΑ
	Input leakage current (for HSB)	$V_{CC} = Max, V_{SS} \le V_{IN} \le V_{CC}$	-100	_	+1	μA
I <sub>OZ</sub>	Off state output leakage current	$\frac{V_{CC} = \underline{Max}, V_{SS} \leq V_{OUT} \leq V_{CC},}{CE \text{ or } OE \geq V_{IH} \text{ or } BHE/BLE \geq V_{IH} \text{ or } \overline{WE} \leq V_{IL}}$	-1	-	+1	μΑ
V <sub>IH</sub>	Input HIGH voltage		2.0	_	V <sub>CC</sub> + 0.5	V
$V_{IL}$	Input LOW voltage		$V_{SS} - 0.5$	_	0.8	V
V <sub>OH</sub>	Output HIGH voltage	I <sub>OUT</sub> = -2 mA	2.4	_	_	V
V <sub>OL</sub>	Output LOW voltage	I <sub>OUT</sub> = 4 mA	_	_	0.4	V

<sup>18.</sup> Typi<u>cal va</u>lues are at 25 °C, V<sub>CC</sub> = V<sub>CC(Typ)</sub>. Not 100% tested.

19. The HSB pin has I<sub>OUT</sub> = -2 µA for V<sub>OH</sub> of 2.4 V when both active HIGH and low drivers are disabled. When they are enabled standard V<sub>OH</sub> and V<sub>OL</sub> are valid. This parameter is characterized but not tested.



### **DC Electrical Characteristics** (continued)

Over the Operating Range

Parameter	Description	Description Test Conditions		Typ <sup>[18]</sup>	Max	Unit
CAP		Between V <sub>CAP</sub> pin and V <sub>SS</sub>	61	68	180	μF
	Maximum voltage driven on $V_{\mbox{\footnotesize CAP}}$ pin by the device	V <sub>CC</sub> = Max	-	_	V <sub>CC</sub>	V

### **Data Retention and Endurance**

Over the Operating Range

Parameter	Description	Min	Unit
DATA <sub>R</sub>	Data retention	20	Years
NV <sub>C</sub>	Nonvolatile STORE operations	1,000	K

### Capacitance

Parameter <sup>[22]</sup>	Description	Test Conditions	Max	Unit
C <sub>IN</sub>	Input capacitance (except BHE, BLE and HSB)	$T_A = 25 ^{\circ}\text{C}, f = 1 \text{MHz}, V_{CC} = V_{CC(Typ)}$	7	pF
	Input capacitance (for BHE, BLE and HSB)		8	pF
C <sub>OUT</sub>	Output capacitance (except HSB)		7	pF
	Output capacitance (for HSB)		8	pF

#### **Thermal Resistance**

Parameter <sup>[22]</sup>	Description	Test Conditions	48-pin SSOP	44-pin TSOP II	54-pin TSOP II	Unit
$\Theta_{JA}$	Thermal resistance (junction to ambient)	Test conditions follow standard test methods and procedures for measuring	37.47	41.74	36.4	°C/W
$\Theta_{JC}$	Thermal resistance (junction to case)	thermal impedance, in accordance with EIA/JESD51.	24.71	11.90	10.13	°C/W

<sup>20.</sup> Min V<sub>CAP</sub> value guarantees that there is a sufficient charge available to complete a successful AutoStore operation. Max V<sub>CAP</sub> value guarantees that the capacitor on V<sub>CAP</sub> is charged to a minimum voltage during a Power-Up RECALL cycle so that an immediate power-down cycle can complete a successful AutoStore. Therefore it is always recommended to use a capacitor within the specified min and max limits. See application note AN43593 for more details on V<sub>CAP</sub> options.

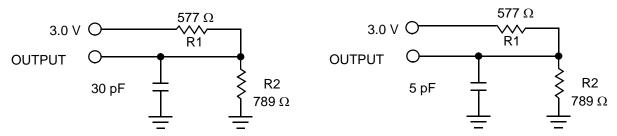
<sup>21.</sup> Maximum voltage on  $V_{CAP}$  pin  $(V_{VCAP})$  is provided for guidance when choosing the  $V_{CAP}$  capacitor. The voltage rating of the  $V_{CAP}$  capacitor across the operating temperature range should be higher than the  $V_{VCAP}$  voltage.

<sup>22.</sup> These parameters are guaranteed by design and are not tested.



#### **AC Test Loads**

Figure 6. AC Test Loads



### **AC Test Conditions**

Input pulse levels	0 V to 3 V
Input rise and fall times (10%–90%)	<u>&lt;</u> 3 ns
Input and output timing reference levels	1.5 V

### **RTC Characteristics**

Over the Operating Range

Parameter	Description	Min	Тур [23]	Max	Units	
V <sub>RTCbat</sub>	RTC battery pin voltage		1.8	3.0	3.6	V
I <sub>BAK</sub> [24]	RTC backup current	T <sub>A</sub> (Min)	-	_	0.35	μA
		25 °C	_	0.35	_	μA
		T <sub>A</sub> (Max)	_	_	0.5	μΑ
V <sub>RTCcap</sub> <sup>[25]</sup>	RTC capacitor pin voltage	T <sub>A</sub> (Min)	1.6	_	3.6	V
		25 °C	1.5	3.0	3.6	V
		T <sub>A</sub> (Max)	1.4	_	3.6	V
tOCS	RTC oscillator time to start	•	_	1	2	sec
t <sub>RTCp</sub>	RTC processing time from end of 'W' bit set to '0'		-	_	350	μs
R <sub>BKCHG</sub>	RTC backup capacitor charge current-limiting resistor		350	_	850	Ω

<sup>23.</sup> These parameters are guaranteed by design and are not tested.

 <sup>24.</sup> From either V<sub>RTCcap</sub> or V<sub>RTCbat</sub>.
 25. If V<sub>RTCcap</sub> > 0.5 V or if no capacitor is connected to V<sub>RTCcap</sub> pin, the oscillator starts in t<sub>OCS</sub> time. If a backup capacitor is connected and V<sub>RTCcap</sub> < 0.5 V, the capacitor must be allowed to charge to 0.5 V for oscillator to start.</li>



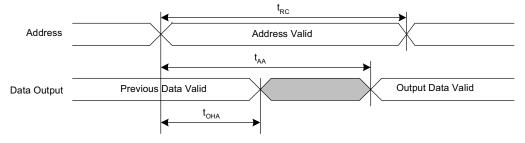
### **AC Switching Characteristics**

Over the Operating Range

Param	eters <sup>[26]</sup>		25	ns	45	ns	
Cypress Parameter Alt Parameter		Description	Min	Max	Min	Max	Unit
SRAM Read Cy	ycle						
t <sub>ACE</sub>	t <sub>ACS</sub>	Chip enable access time	_	25	_	45	ns
t <sub>RC</sub> <sup>[27]</sup>	t <sub>RC</sub>	Read cycle time	25	_	45	_	ns
t <sub>AA</sub> <sup>[28]</sup>	t <sub>AA</sub>	Address access time	_	25	_	45	ns
t <sub>DOF</sub>	t <sub>OE</sub>	Output enable to data valid	_	12	_	20	ns
t <sub>OHA</sub> <sup>[28]</sup>	t <sub>OH</sub>	Output hold after address change	3	_	3	_	ns
t <sub>1.70=</sub> [29, 30]	t <sub>LZ</sub>	Chip enable to output active	3	-	3	-	ns
t <sub>HZCE</sub> [29, 30]	t <sub>HZ</sub>	Chip disable to output inactive	_	10	_	15	ns
t <sub>LZOE</sub> [29, 30]	t <sub>OLZ</sub>	Output enable to output active	0	_	0	_	ns
t <sub>HZOE</sub> [29, 30]	t <sub>OHZ</sub>	Output disable to output inactive	_	10	_	15	ns
t <sub>PU</sub> <sup>[29]</sup>	t <sub>PA</sub>	Chip enable to power active	0	_	0	_	ns
t <sub>PD</sub> <sup>[29]</sup>	t <sub>PS</sub>	Chip disable to power standby	_	25	_	45	ns
t <sub>DBF</sub>	-	Byte enable to data valid	_	12	_	20	ns
t <sub>LZBE</sub> [29]	-	Byte enable to output active	0	_	0	_	ns
t <sub>HZBE</sub> <sup>[29]</sup>	_	Byte disable to output inactive	_	10	_	15	ns
SRAM Write C	ycle		•			•	
t <sub>WC</sub>	t <sub>WC</sub>	Write cycle time	25	_	45	_	ns
t <sub>PWE</sub>	t <sub>WP</sub>	Write pulse width	20	_	30	_	ns
t <sub>SCE</sub>	t <sub>CW</sub>	Chip enable to end of write	20	_	30	-	ns
t <sub>SD</sub>	t <sub>DW</sub>	Data setup to end of write	10	_	15	-	ns
t <sub>HD</sub>	t <sub>DH</sub>	Data hold after end of write	0	_	0	_	ns
t <sub>AW</sub>	t <sub>AW</sub>	Address setup to end of write	20	_	30	_	ns
t <sub>SA</sub>	t <sub>AS</sub>	Address setup to start of write	0	_	0	_	ns
t <sub>HA</sub>	t <sub>WR</sub>	Address hold after end of write	0	_	0	_	ns
t <sub>HZWE</sub> [29, 30, 31]	t <sub>WZ</sub>	Write enable to output disable	-	10	-	15	ns
t <sub>LZWE</sub> [29, 30]	t <sub>OW</sub>	Output active after end of write	3	-	3	-	ns
t <sub>BW</sub>	_	Byte enable to end of write	20	-	30	-	ns

### **Switching Waveforms**

Figure 7. SRAM Read Cycle #1 (Address Controlled)  $^{[27,\,28,\,32]}$ 



- 26. Test conditions assume signal transition time of 3 ns or less, timing reference levels of V<sub>CC</sub>/2, input pulse levels of 0 to V<sub>CC(typ)</sub>, and output loading of the specified I<sub>CI</sub>/I<sub>OH</sub> and load capacitance shown in Figure 6 on page 18.

  27. WE must be HIGH during SRAM read cycles.

  28. Device is continuously selected with CE, OE, and BHE/BLE LOW.

- 29. These parameters are guaranteed by design and are not tested.
- 30. Measured ±200 mV from steady state output voltage.
  31. If WE is low when CE goes low, the outputs remain in the high impedance state.
- 32. HSB must remain HIGH during Read and Write cycles.



### Switching Waveforms (continued)

Figure 8. SRAM Read Cycle #2 (CE and OE Controlled) [33, 34, 35]

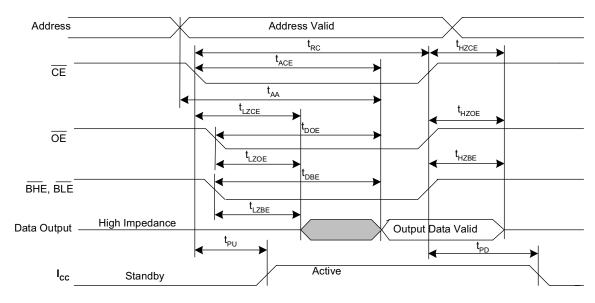
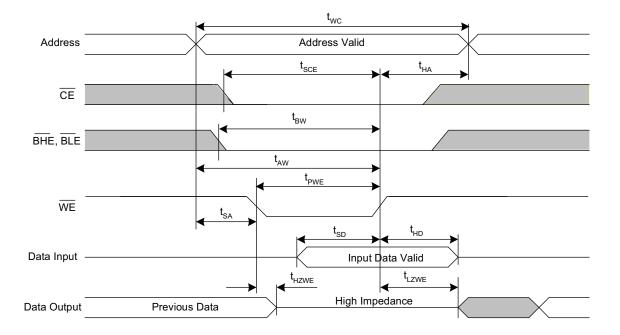


Figure 9. SRAM Write Cycle #1 ( $\overline{\text{WE}}$  Controlled)  $^{[33,\ 35,\ 36,\ 37]}$ 



- 33. BHE and BLE are applicable for x 16 configuration only.

  34. WE must be HIGH during SRAM read cycles.

  35. HSB must remain HIGH during read and write cycles.

- 36. If  $\overline{\text{WE}}$  is LOW when  $\overline{\text{CE}}$  goes LOW, the outputs remain in the high impedance state. 37.  $\overline{\text{CE}}$  or  $\overline{\text{WE}}$  must be  $\geq$  V<sub>IH</sub> during address transitions.



### Switching Waveforms (continued)

Figure 10. SRAM Write Cycle #2 (CE Controlled) [38, 39, 40, 41]

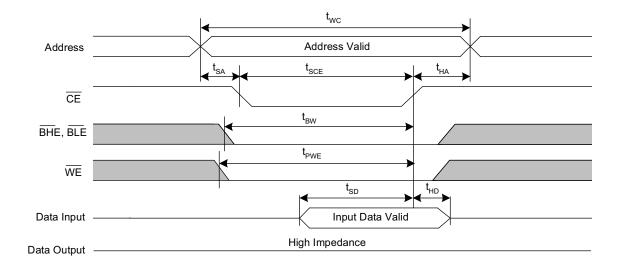
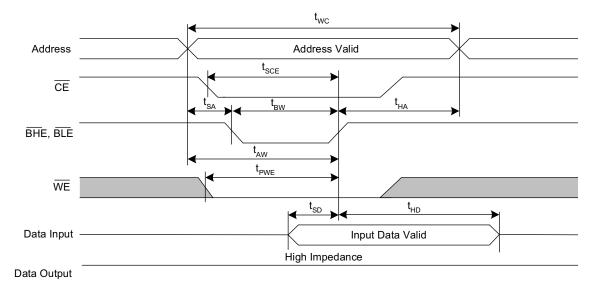


Figure 11. SRAM Write Cycle #3 (BHE and BLE Controlled) [39, 40, 41, 42, 43]

(Not applicable for RTC register writes)



- 38. BHE and BLE are applicable for × 16 configuration only.

  39. If WE is LOW when CE goes LOW, the outputs remain in the high impedance state.

  40. HSB must remain HIGH during read and write cycles.

- 40. All the properties of the prop



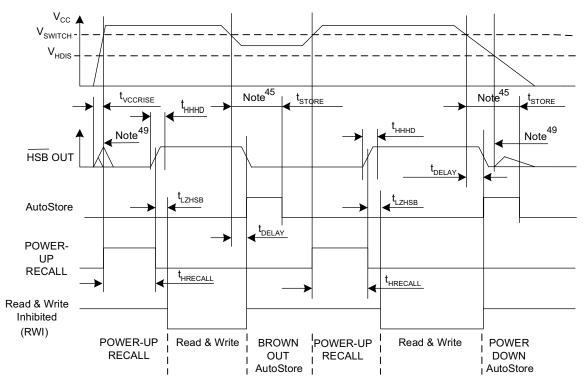
### **AutoStore/Power-Up RECALL**

Over the Operating Range

Parameter	Description	CY14B101KA/	Unit	
Parameter	Description	Min	Max	Onit
t <sub>HRECALL</sub> [44]	Power-Up RECALL duration	_	20	ms
t <sub>STORE</sub> [45]	STORE cycle duration	_	8	ms
t <sub>DELAY</sub> [46]	Time allowed to complete SRAM write cycle	_	25	ns
V <sub>SWITCH</sub>	Low voltage trigger level	_	2.65	V
t <sub>VCCRISE</sub> [47]	V <sub>CC</sub> rise time	150	_	μs
V <sub>HDIS</sub> <sup>[47]</sup>	HSB output disable voltage	_	1.9	V
t <sub>LZHSB</sub> <sup>[47]</sup>	HSB to output active time	_	5	μs
t <sub>HHHD</sub> [47]	HSB high active time	_	500	ns

### **Switching Waveforms**

Figure 12. AutoStore or Power-Up RECALL [48]



- 44. t<sub>HRECALL</sub> starts from the time V<sub>CC</sub> rises above V<sub>SWITCH</sub>.
  45. If an SRAM write has not taken place since the last nonvolatile cycle, no AutoStore or Hardware STORE takes place
- 46. On a Hardware STORE and AutoStore initiation, SRAM write operation continues to be enabled for time t<sub>DELAY</sub>.
- 47. These parameters are guaranteed by design and are not tested.
- 48. Read and Write cycles are ignored during STORE, RECALL, and while V<sub>CC</sub> is below V<sub>SWITCH</sub>.
  49. During power-up and power-down, HSB glitches when HSB pin is pulled up through an external resistor.



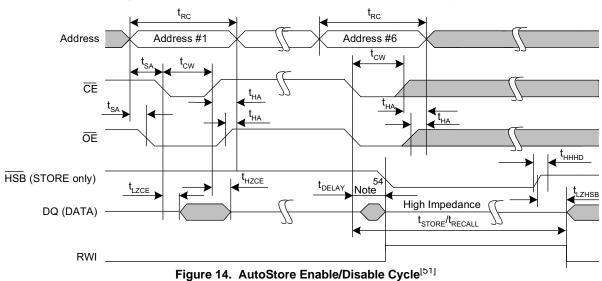
### **Software Controlled STORE/RECALL Cycle**

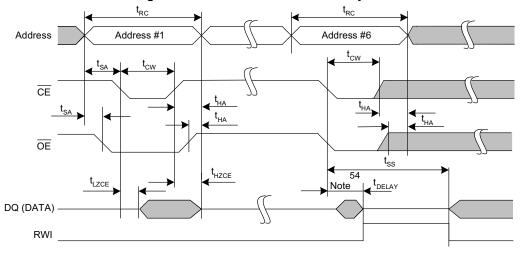
Over the Operating Range

Parameter [50, 51]	Description	25 ns		45 ns		Unit
raiameter	Description	Min	Max	Min	Max	Oilit
t <sub>RC</sub>	STORE/RECALL initiation cycle time	25	_	45	_	ns
t <sub>SA</sub>	Address setup time	0	_	0	_	ns
t <sub>CW</sub>	Clock pulse width	20	_	30	_	ns
t <sub>HA</sub>	Address hold time	0	_	0	_	ns
t <sub>RECALL</sub>	RECALL duration	_	200	_	200	μs
t <sub>SS</sub> [52, 53]	Soft sequence processing time	-	100	I	100	μs

### **Switching Waveforms**

Figure 13. CE & OE Controlled Software STORE/RECALL Cycle [51]





- 50. The software sequence is clocked with  $\overline{\text{CE}}$  controlled or  $\overline{\text{OE}}$  controlled reads.
  51. The six consecutive addresses must be read in the order listed in Table 1.  $\overline{\text{WE}}$  must be HIGH during all six consecutive cycles.
- 51. The six consecutive addresses finds to elead in the order instead in Table 1. We find to be find find during all six consecutive cycles.

  52. This is the amount of time it takes to take action on a soft sequence command. Vcc power must remain HIGH to effectively register command.

  53. Commands such as STORE and RECALL lock out I/O until operation is complete which further increases this time. See the specific command.

  54. DQ output data at the sixth read may be invalid since the output is disabled at t<sub>DELAY</sub> time.



### **Hardware STORE Cycle**

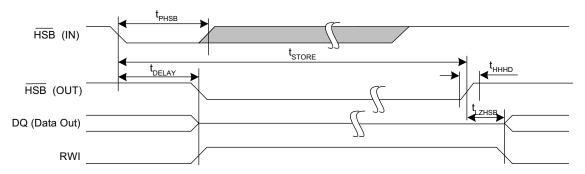
Over the Operating Range

Parameter	Description	CY14B101KA/	Unit	
raiametei	Description	Min	Max	Oille
t <sub>DHSB</sub>	HSB to output active time when write latch not set	_	25	ns
t <sub>PHSB</sub>	Hardware STORE pulse width	15	_	ns

### **Switching Waveforms**

Figure 15. Hardware STORE Cycle [55]

#### Write latch set



#### Write latch not set

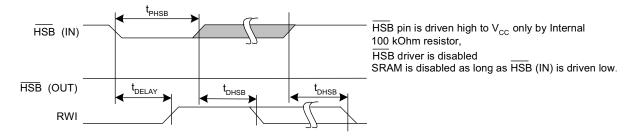
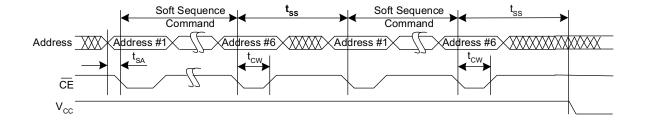


Figure 16. Soft Sequence Processing [56, 57]



- 55. If an SRAM write has not taken place since the last nonvolatile cycle, no AutoStore or Hardware STORE takes place.
- 56. This is the amount of time it takes to take action on a soft sequence command.  $V_{CC}$  power must remain HIGH to effectively register command.
- 57. Commands such as STORE and RECALL lock out I/O until operation is complete which further increases this time. See the specific command.



### **Truth Table For SRAM Operations**

HSB must remain HIGH for SRAM operations.

#### Table 5. Truth Table for x 8 Configuration

CE	WE	OE	Inputs/Outputs <sup>[58]</sup>	Mode	Power
Н	Х	Х	High Z	Deselect/Power-down	Standby
L	Н	L	Data out (DQ <sub>0</sub> –DQ <sub>7</sub> )	Read	Active
L	Н	Η	High Z	Output disabled	Active
L	L	Х	Data in (DQ <sub>0</sub> –DQ <sub>7</sub> )	Write	Active

#### Table 6. Truth Table for x 16 Configuration

	able of that table for a to configuration								
CE	WE	OE	BHE <sup>[59]</sup>	<b>BLE</b> [59]	Inputs/Outputs <sup>[58]</sup>	Mode	Power		
Н	Х	Х	Х	Х	High Z	Deselect/Power-down	Standby		
L	Х	Х	Н	Н	High Z	Output disabled	Active		
L	Н	L	L	L	Data out (DQ <sub>0</sub> -DQ <sub>15</sub> )	Read	Active		
L	Н	L	Н	L	Data out (DQ <sub>0</sub> –DQ <sub>7</sub> ) DQ <sub>8</sub> –DQ <sub>15</sub> in High Z	Read	Active		
L	Н	L	L	Н	Data out (DQ <sub>8</sub> –DQ <sub>15</sub> ) DQ <sub>0</sub> –DQ <sub>7</sub> in High Z	Read	Active		
L	Н	Н	L	L	High Z	Output disabled	Active		
L	Н	Н	Н	L	High Z	Output disabled	Active		
L	Н	Н	L	Н	High Z	Output disabled	Active		
L	L	Х	L	L	Data in (DQ <sub>0</sub> -DQ <sub>15</sub> )	Write	Active		
L	L	Х	Н	L	Data in (DQ <sub>0</sub> –DQ <sub>7</sub> ) DQ <sub>8</sub> –DQ <sub>15</sub> in High Z	Write	Active		
L	L	Х	L	Н	Data in (DQ <sub>8</sub> –DQ <sub>15</sub> ) DQ <sub>0</sub> –DQ <sub>7</sub> in High Z	Write	Active		

<sup>58. &</sup>lt;u>Data</u> DQ<sub>0</sub><u>DQ</u><sub>7</sub> for × 8 configuration and Data DQ<sub>0</sub>DQ<sub>15</sub> for × 16 configuration. 59. BHE and BLE are applicable for × 16 configuration only.



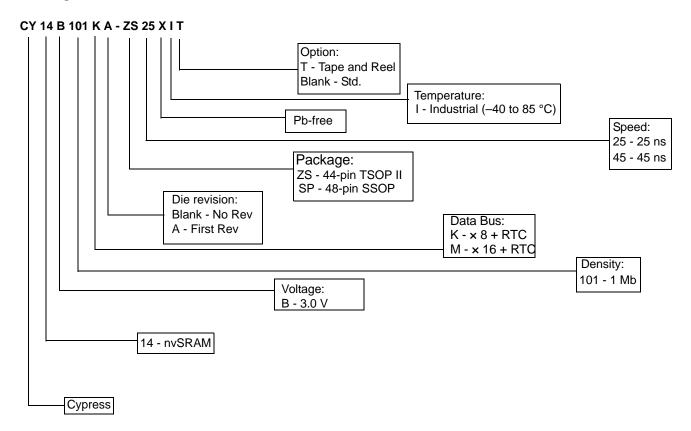
### **Ordering Information**

Cypress offers other versions of this type of product in many different configurations and features. The below table contains only the list of parts that are currently available. For a complete listing of all options, visit the Cypress website at <a href="https://www.cypress.com/products">www.cypress.com/products</a> or contact your local sales representative. Cypress maintains a worldwide network of offices, solution centers, manufacturer's representatives and distributors. To find the office closest to you, visit us at <a href="http://www.cypress.com/go/datasheet/offices">http://www.cypress.com/go/datasheet/offices</a>.

Speed (ns)	Ordering Code	Package Diagram	Package Type	Operating Range
25	CY14B101KA-ZS25XIT	51-85087	44-pin TSOP II	Industrial
	CY14B101KA-ZS25XI	51-85087	44-pin TSOP II	
	CY14B101KA-SP25XIT	51-85061	48-pin SSOP	
	CY14B101KA-SP25XI	51-85061	48-pin SSOP	
45	CY14B101KA-ZS45XIT	51-85087	44-pin TSOP II	
	CY14B101KA-ZS45XI	51-85087	44-pin TSOP II	
	CY14B101KA-SP45XIT	51-85061	48-pin SSOP	
	CY14B101KA-SP45XI	51-85061	48-pin SSOP	

All the above parts are Pb-free.

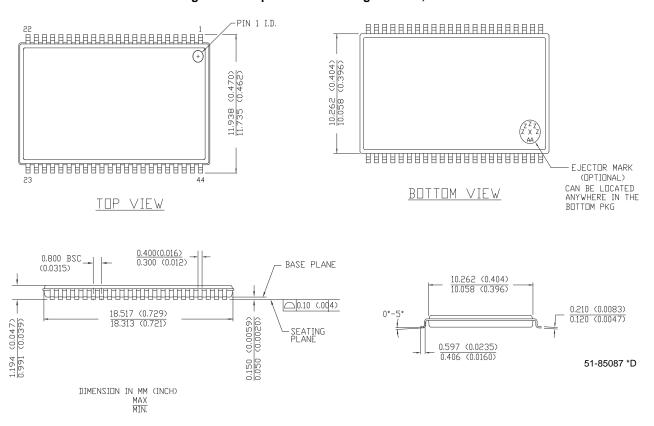
#### **Ordering Code Definitions**





### **Package Diagrams**

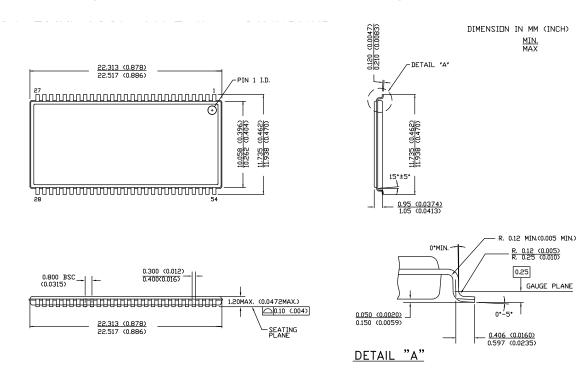
Figure 17. 44-pin TSOP II Package Outline, 51-85087





# Package Diagrams (continued)

Figure 18. 54-pin TSOP II (22.4 × 11.84 × 1.0 mm) Package Outline, 51-85160

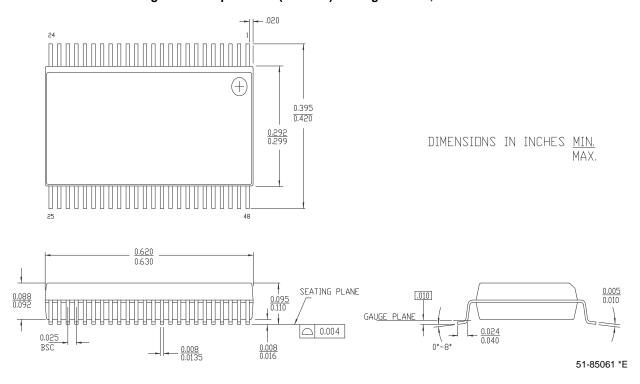


51-85160 \*D



### Package Diagrams (continued)

Figure 19. 48-pin SSOP (300 Mils) Package Outline, 51-85061





## **Acronyms**

Acronym	Description		
BCD binary coded decimal			
BHE byte high enable			
BLE	byte low enable		
CE	chip enable		
CMOS	complementary metal oxide semiconductor		
EIA	electronic industries alliance		
HSB hardware store busy			
I/O input/output			
nvSRAM nonvolatile static random access memory			
ŌĒ	output enable		
RoHS	restriction of hazardous substances		
RWI	read and write inhibited		
RTC	real time clock		
SRAM	static random access memory		
SSOP shrink small outline package			
TSOP	thin small outline package		
WE	write enable		

### **Document Conventions**

### **Units of Measure**

Symbol	Unit of Measure
°C	degree Celsius
F	farad
Hz	hertz
kbit	1024 bits
kHz	kilohertz
kΩ	kilohm
MHz	megahertz
μΑ	microampere
μF	microfarad
μs	microsecond
mA	milliampere
ms	millisecond
ns	nanosecond
Ω	ohms
%	percent
pF	picofarad
ppm	parts per million
V	volt
W	watt



# **Document History Page**

cument Number: 00  Rev. ECN No.	Submission	Orig. of	Description of Change
	Date	Change	·
** 2050747	See ECN	UNC / PYRS	New data sheet.
*A 2607447	11/18/2008	GVCH / AESA	Removed 15 ns access speed, updated "Features", added CY14B101MA (x16) part, changed title to "CY14B101KA/CY14B101MA, 1-Mbit (128K x 8/64K x 16) nvSRAM with Real-Time-Clock". Added 54-pin TSOP II package related information, updated Logic block diagram, added footnote 1 and 2. Pin definition: Updated WE, HSB and NC pin description. Page 4: Updated SRAM READ, SRAM WRITE, Autostore operation description, Page 4: Updated Software store and software recall description Updated Figure 2, Page 4: Updated Hardware store operation and Hardware RECALL (Power up) description Footnote 1 and 10 referenced for Mode selection Table Added footnote 10, updated footnote 8 and 9 Page 6: updated Data protection description Page 6: Updated Starting and stopping the oscillator description Page 7: Updated Calibrating the clock description Page 7: Updated Calibrating the clock description Page 8: Added Flags register Updated table 4, added footnote 12 and 13 Updated Register map detail Table 5 Maximum Ratings: Added Max. Accumulated storage time Changed Output short circuit current parameter name to DC output current Changed I <sub>CC2</sub> from 6 mA to 5 mA Changed I <sub>CC3</sub> from 6 mA to 5 mA Changed I <sub>CC4</sub> from 6 mA to 5 mA Changed I <sub>CC4</sub> from 6 mA to 5 mA Changed I <sub>CC4</sub> proltage max value to 180uF Updated footnote 14 and 15, added footnote 16 Added Data retention and Endurance Table Added V <sub>CAP</sub> voltage max value to 44/54 TSOP II packages Updated Input Rise and Fall time in AC test Conditions Changed V <sub>RTCcap min</sub> value from 1.2 to 1.5V for industrial Commercial temperature Changed V <sub>RTCcap min</sub> value from 2.7 to 3.6V for industrial Commercial temperature Updated RTC recommended component configuration values Updated Figure 11 (SRAM WRITE CYCLE:BHE and BLE controlled) Changed t <sub>STCRE</sub> max value from 15ms to 8ms Updated footnote 22, added footnote 25 and 5 Eccentrolled STORE/RECALL



## **Document History Page** (continued)

Rev.	ECN No.	Submission Date	Orig. of Change	Description of Change
*B	2654484	02/05/09	GVCH/ PYRS	Changed the data sheet from Advance information to Preliminary Changed X <sub>1</sub> , X <sub>2</sub> pin names to X <sub>out</sub> , X <sub>in</sub> respectively Updated Real Time Clock operation description Added footnotes 11 and 12 Added default values to RTC Register Map" table 3 Updated flag register description in Register Map Detail" table 4 Changed C1, C2 values to 21pF, 21pF respectively Changed I <sub>BAK</sub> value from 350 nA to 450 nA at hot temperature Changed V <sub>RTCcap</sub> typical value from 2.4V to 3.0V Referenced Note 15 to parameters t <sub>LZCE</sub> , t <sub>HZCE</sub> , t <sub>LZOE</sub> , t <sub>LZOE</sub> , t <sub>LZDE</sub> , t <sub>LZWE</sub> t <sub>HZWE</sub> and t <sub>HZBE</sub> Added footnote 24 Updated Figure 13
*C	2733909	07/09/09	GVCH / AESA	Page 3; Added note to AutoStore Operation description Page 4; Updated Hardware STORE (HSB) Operation description Page 4; Updated Software STORE Operation description Added best practices Changed C1, C2 values to 10pF, 67pF respectively Changed I <sub>BAK</sub> and V <sub>RTCcap</sub> parameter values Added R <sub>BKCHG</sub> parameter Updated V <sub>HDIS</sub> parameter description Updated t <sub>DELAY</sub> parameter description Updated footnote 28 and added footnote 35
*D	2757375	08/28/09	GVCH	Moved data sheet status from Preliminary to Final Removed commercial temperature related specs Removed 20ns access speed related specs Updated Thermal resistance values for all the packages Changed $V_{RTCbat}$ max value from 3.3V to 3.6V Changed $R_{BKCHG}$ min value from $450\Omega$ to $350\Omega$ Updated footnote 18
*E	2767333	01/06/10	GVCH / PYRS	Changed STORE cycles to QuantumTrap from 200K to 1 Million Added Data Retention and Endurance table Updated I <sub>BAK</sub> RTC backup current spec unit from nA to μA Added Contents.
*F	2899937	03/26/10	GVCH	Added more clarity on HSB pin operation Table 1: Added more clarity on BHE/BLE pin operation Updated HSB pin operation in Switching Waveforms Updated footnote 30 Updated Ordering Information table. Updated package diagrams. Updated copyright section.
*G	3134300	01/11/2011	GVCH	Updated Setting the Clock description Added footnote 15 Updated 'W' bit description in Register Map Detail table Updated best practices Updated input capacitance for BHE and BLE pin Updated input and output capacitance for HSB pin Added t <sub>RTCp</sub> parameter to RTC Characteristics table Figure 12: Typo error fixed Added Acronyms table and Document Conventions table
*H	3150308	01/21/2011	GVCH	No technical updates.



## **Document History Page** (continued)

Rev.	ECN No.	Submission Date	Orig. of Change	Description of Change
*	3313245	07/14/2011	GVCH	Updated DC Electrical Characteristics (Added Note 19 and referred the same note in V <sub>CAP</sub> parameter).  Updated AC Switching Characteristics (Added Note 26 and referred the same note in Parameters).
*J	3500268	01/18/2012	GVCH	Added footnote 8 and 12.
*K	3659138	08/14/2012	GVCH	Updated Real Time Clock Operation (description). Updated Maximum Ratings (Changed "Ambient temperature with power applied" to "Maximum junction temperature"). Updated DC Electrical Characteristics (Added V <sub>VCAP</sub> parameter and its details, added Note 21 and referred the same note in V <sub>VCAP</sub> parameter, also referred Note 22 in V <sub>VCAP</sub> parameter). Updated Package Diagrams (spec 51-85160 (Changed revision from *C to *D)).



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### Офис по работе с юридическими лицами:

105318, г. Москва, ул. Щербаковская д. 3, офис 1107, 1118, ДЦ «Щербаковский»

Телефон: +7 495 668-12-70 (многоканальный)

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Skype отдела продаж:

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